

PATENT Customer No. 22,852 Attorney Docket No. 04329.2509

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:	)
Kazuya Sato et al.	) Group Art Unit: 2877
Application No.: 09/783,295	Examiner: to be assigned:
Filed: February 15, 2001	800 F.NE.NE.
For: METHOD FOR INSPECTING EXPOSURE APPARATUS	ALL ROLL
Commissioner for Patents	3

Sir:

Washington, DC 20231

## SUPPLEMENTAL INFORMATION DISCLOSURE STATEMENT UNDER 37 C.F.R. § 1.97(b)

Pursuant to 37 C.F.R. §§ 1.56 and 1.97(b), applicant brings to the attention of the Examiner the documents listed on the attached PTO 1449. This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits for the above-referenced application.

Copies of the listed documents, including any copending patent applications, are attached. Further Japanese KOKAI Pub. No. 2000-21732 was previously submitted in an Information Disclosure Statement on February 15, 2001.

The following is a supplemental concise statement of relevance of the non-English language document.

Japanese KOKAl Pub. No. 2000-21732 discloses a method of inspecting an exposure apparatus, the exposure apparatus comprising an illumination optical system

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1 that guides light emitted from a light source to a reticle 2, and a projection optical system 3 that transfers a reduced projection image of the reticle 2 onto a wafer 5, the method inspecting a form of the light source of the exposure apparatus, a form of pupil 4 of the projection optical system 3, and a concentricity between the light source form and the form of the pupil 4, wherein the reticle 2 includes a grating pattern in which a light transmission part and opaque part are repeated at finite periods, a light is irradiated onto the reticle 2, and a primary diffraction light that has passed through the reticle 2 is irradiated onto an outer edge of the pupil 4 of the projection optical system 3, and a pattern image of the reticle 2 is formed by exposure on a wafer 5 in a defocused state.

Additionally, Japanese KOKAI Publication No. 2000-21732 corresponds to U.S. Patent No, 6,317,198 also being submitted herewith.

This submission does not represent that a search has been made or that no better art exists and does not constitute an admission that each or all of the listed documents are material or constitute "prior art." If the Examiner applies any of the documents as prior art against any claim in the application and Applicants determine that the cited document do not constitute "prior art" under United States law, Applicants reserves the right to present to the office the relevant facts and law regarding the appropriate status of such documents.

Applicants further reserves the right to take appropriate action to establish the patentability of the disclosed invention over the listed documents, should one or more of the documents be applied against the claims of the present application.

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If there is any fee due in connection with the filing of this Statement, please charge the fee to our Deposit Account No. 06-0916.

Respectfully submitted,

FINNEGAN, HENDERSON, FARABOW, GARRETT & DUNNER, L.L.P.

Dated: May 3, 2002

By: / VI Richard V. Burgujia

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## INFORMATION DISCLOSURE CITATION

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Atty Cocket No.	329.2509	Appln. No.	09/783,295		
Applicant	Kazuya Sato et al.				
Filing Date	February 15, 2001	Group:	2877	·	

	U.S. PATENT DOCUMENTS						
Examiner Initial*		Document Number	Issue Date	Name	Class	Sub Class	Filing Date If Appropriate
	6	US 6,317,198	Nov. 13, 2001	Sato et al.			
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FOREIGN PATENT DOCUMENTS						
	Document Number	Publication Date	Country	Class	Sub Class	Translation Yes or No
	Japanese KOKAI Pub. No. 2000- 21732					Abstract
	-					

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)						
					- 41	

Examiner Date Considered			
*Examiner:	Initial if reference consid through citation if not in communication to applic	ered, whether or not citation is in conformance with MPEP 609; draw line conformance and not considered. Include copy of this form with next ant.	
Form PTO 14	149	Patent and Trademark Office - U.S. Department of Commerce	